

Absolute Maximum Ratings T_c = 25°C unless otherwise noted

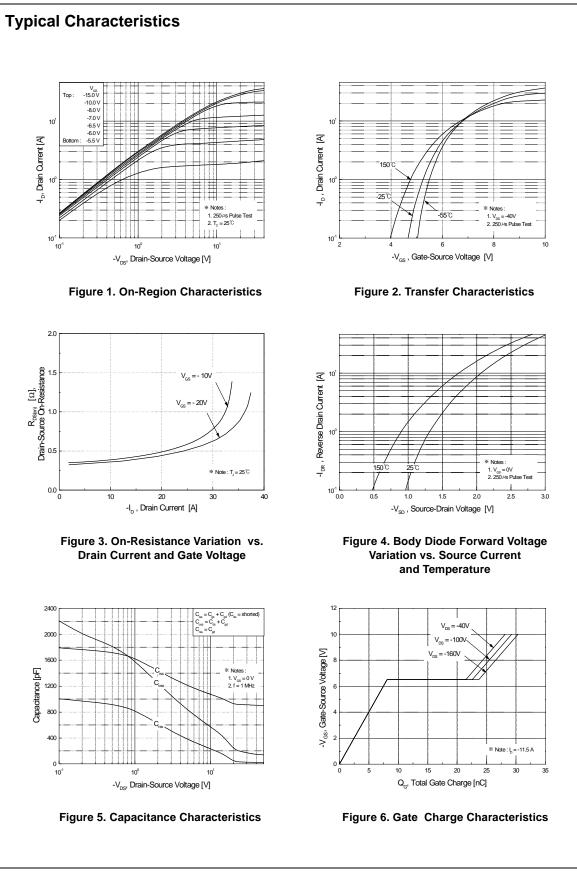
Symbol	Parameter		FQB12P20 / FQI12P20	Units
V _{DSS}	Drain-Source Voltage		-200	V
I _D	Drain Current - Continuous ($T_c = 25^{\circ}C$)		-11.5	А
	- Continuous (T _C = 100°C)		-7.27	А
I _{DM}	Drain Current - Pulsed	(Note 1)	-46	А
V _{GSS}	Gate-Source Voltage		± 30	V
E _{AS}	Single Pulsed Avalanche Energy	(Note 2)	810	mJ
I _{AR}	Avalanche Current	(Note 1)	-11.5	А
E _{AR}	Repetitive Avalanche Energy	(Note 1)	12	mJ
dv/dt	Peak Diode Recovery dv/dt	(Note 3)	-5.5	V/ns
P _D	Power Dissipation $(T_A = 25^{\circ}C)^{*}$		3.13	W
	Power Dissipation ($T_c = 25^{\circ}C$)		120	W
	- Derate above 25°C		0.96	W/°C
T _J , T _{STG}	Operating and Storage Temperature Range		-55 to +150	°C
TL	Maximum lead temperature for soldering purposes, 1/8" from case for 5 seconds		300	°C

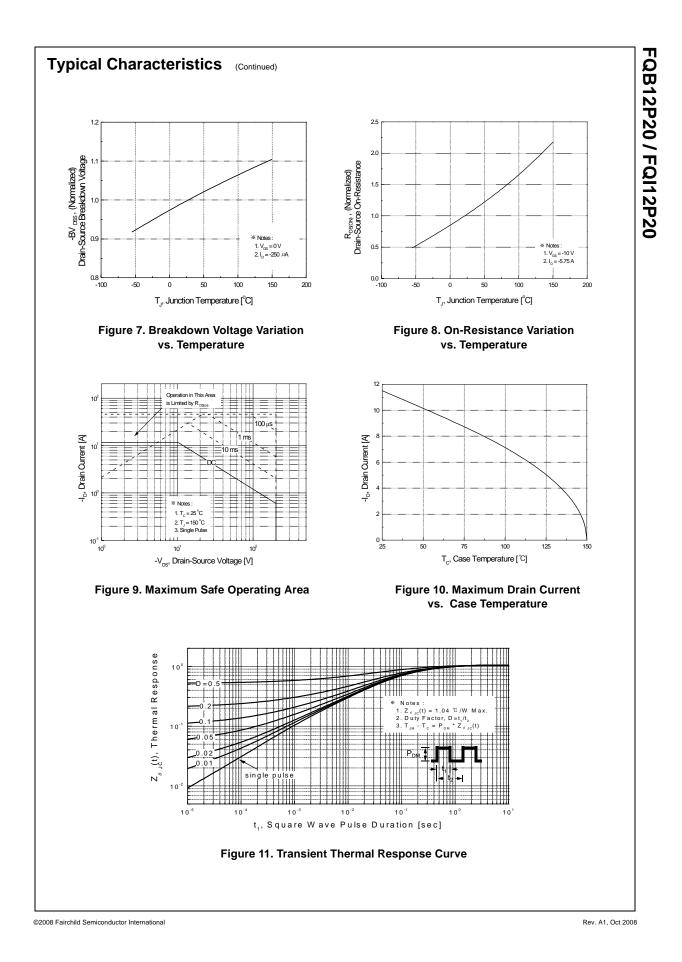
Thermal Characteristics

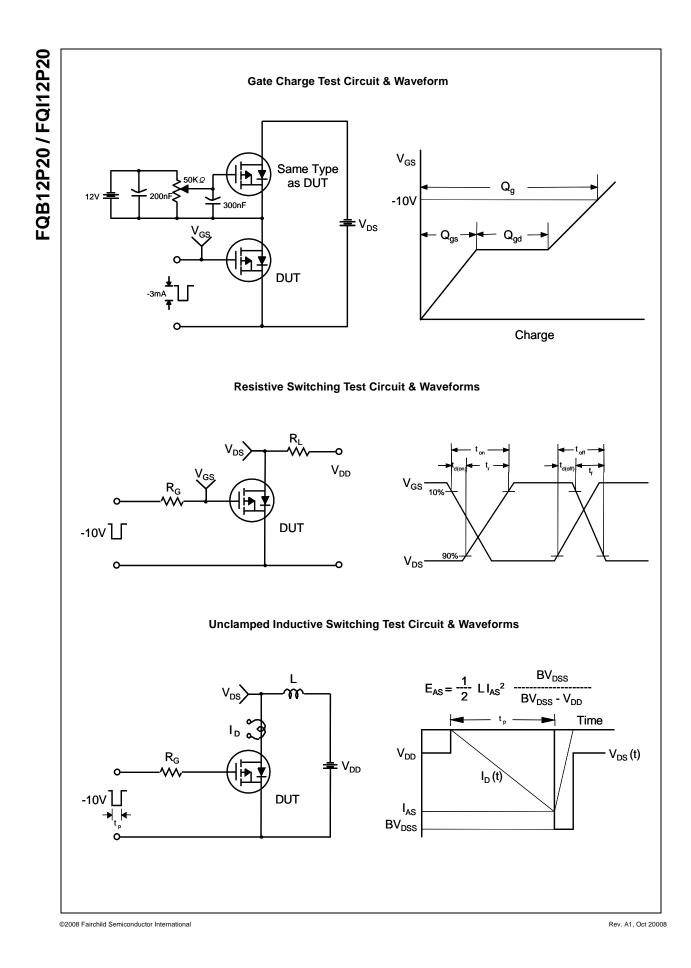
Symbol	Parameter	Тур	Max	Units
$R_{ extsf{ heta}JC}$	Thermal Resistance, Junction-to-Case		1.04	°C/W
R_{\thetaJA}	Thermal Resistance, Junction-to-Ambient *		40	°C/W
$R_{\theta JA}$	Thermal Resistance, Junction-to-Ambient		62.5	°C/W

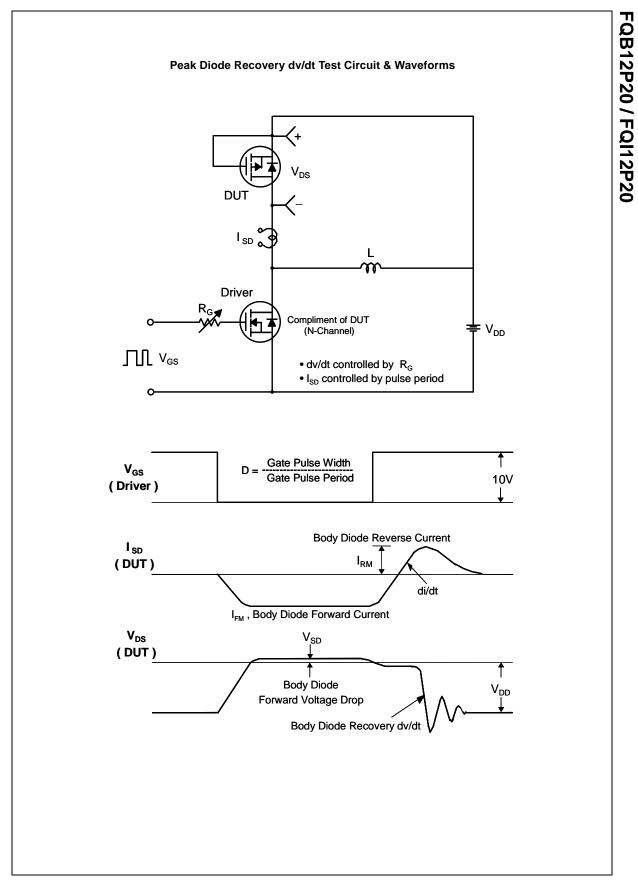
Off Cha	Parameter	Test Conditions	Min	Тур	Max	Units
BV _{DSS}	ractariation					
W D O O	Drain-Source Breakdown Voltage	V _{GS} = 0 V, I _D = -250 μA	-200			V
BV _{DSS}	Breakdown Voltage Temperature					v
ΔT_{J}	Coefficient	$I_D = -250 \ \mu$ A, Referenced to 25°C		-		V/°C
DSS	Zero Gate Voltage Drain Current	$V_{DS} = -200 \text{ V}, \text{ V}_{GS} = 0 \text{ V}$			-1	μA
	Zero Gale Voltage Drain Current	V _{DS} = -160 V, T _C = 125°C			-10	μΑ
GSSF	Gate-Body Leakage Current, Forward	$V_{GS} = -30 \text{ V}, V_{DS} = 0 \text{ V}$			-100	nA
GSSR	Gate-Body Leakage Current, Reverse	$V_{GS} = 30 \text{ V}, V_{DS} = 0 \text{ V}$			100	nA
)n Cha	racteristics					
GS(th)	Gate Threshold Voltage	V _{DS} = V _{GS} , I _D = -250 μA	-3.0		-5.0	V
R _{DS(on)}	Static Drain-Source					
20(01)	On-Resistance	V_{GS} = -10 V, I_{D} = -5.75 A		0.36	0.47	Ω
IFS	Forward Transconductance	$V_{DS} = -40 \text{ V}, \text{ I}_{D} = -5.75 \text{ A}$ (Note 4)		6.4		S
)vnami	c Characteristics					
viss	Input Capacitance	N 05 X X 0 X		920	1200	pF
oss	Output Capacitance	V _{DS} = -25 V, V _{GS} = 0 V, f = 1.0 MHz		190	250	pF
rss	Reverse Transfer Capacitance	1 = 1.0 MHz		30	40	pF
155				00	40	Р
witchi	ng Characteristics					
	ng Characteristics Turn-On Delay Time)/ _ 100)/ I _ 11.5 A		20	50	ns
d(on)	•	$V_{DD} = -100 \text{ V}, \text{ I}_{D} = -11.5 \text{ A},$		20 195	50 400	ns ns
	Turn-On Delay Time	V_{DD} = -100 V, I _D = -11.5 A, R _G = 25 Ω				
d(on)	Turn-On Delay Time Turn-On Rise Time			195	400	ns
d(on) - d(off)	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time	R _G = 25 Ω (Note 4, 5)		195 40	400 90	ns ns
d(on) d(off)	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time	$R_{G} = 25 \Omega$ (Note 4, 5) V _{DS} = -160 V, I _D = -11.5 A,		195 40 60	400 90 130	ns ns ns
d(on) - d(off)	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge	R _G = 25 Ω (Note 4, 5)	 	195 40 60 31	400 90 130 40	ns ns ns nC
d(on) d(off) 2 _g 2 _{gs} 2 _{gd} Drain-S	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge	$R_{G} = 25 Ω$ (Note 4, 5) $V_{DS} = -160 V, I_{D} = -11.5 A,$ $V_{GS} = -10 V$ (Note 4, 5) (Note 4, 5)	 	195 40 60 31 8.1	400 90 130 40 	ns ns nC nC nC
d(on) d(off) ag Ag Ags Agd Drain-So S	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge ource Diode Characteristics ar	$R_{G} = 25 \Omega$ (Note 4, 5) $V_{DS} = -160 V, I_{D} = -11.5 A,$ $V_{GS} = -10 V$ (Note 4, 5) (Note 4,	 	195 40 60 31 8.1 16	400 90 130 40 	ns ns nC nC nC A
d(on) d(off) d(off) dgg Qgs Qgs Qgd Drain-So SM	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge ource Diode Characteristics ar Maximum Continuous Drain-Source Diode F	$R_{G} = 25 \Omega$ (Note 4, 5) $V_{DS} = -160 V, I_{D} = -11.5 A,$ $V_{GS} = -10 V$ (Note 4, 5) (Note 4,	 	195 40 60 31 8.1 16	400 90 130 40 -11.5 -46	ns ns nC nC nC A A
d(on) d(off) ag Ag Ags Agd Drain-So S	Turn-On Delay Time Turn-On Rise Time Turn-Off Delay Time Turn-Off Fall Time Total Gate Charge Gate-Source Charge Gate-Drain Charge ource Diode Characteristics ar Maximum Continuous Drain-Source Dio	$R_{G} = 25 \Omega$ (Note 4, 5) $V_{DS} = -160 V, I_{D} = -11.5 A,$ $V_{GS} = -10 V$ (Note 4, 5) (Note 4,	 	195 40 60 31 8.1 16 	400 90 130 40 	ns ns nC nC nC A

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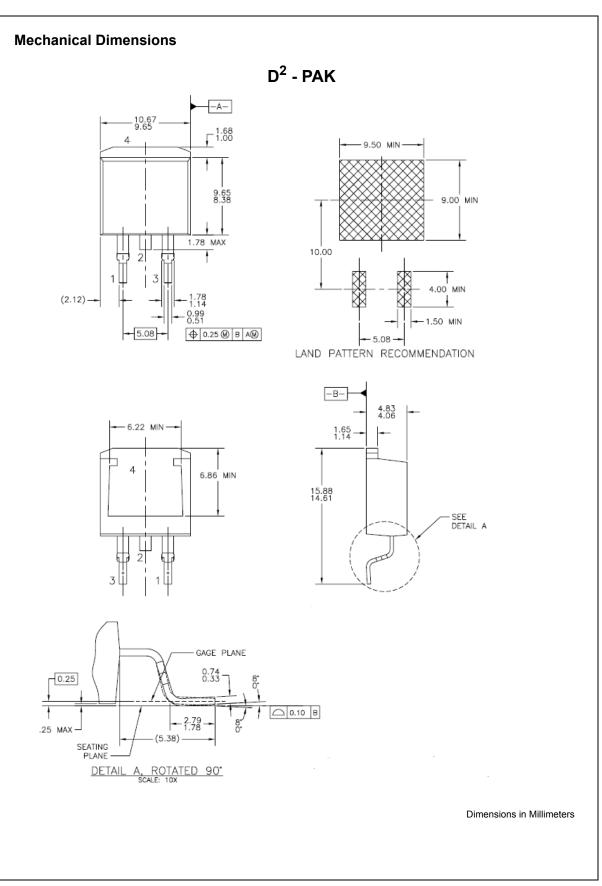


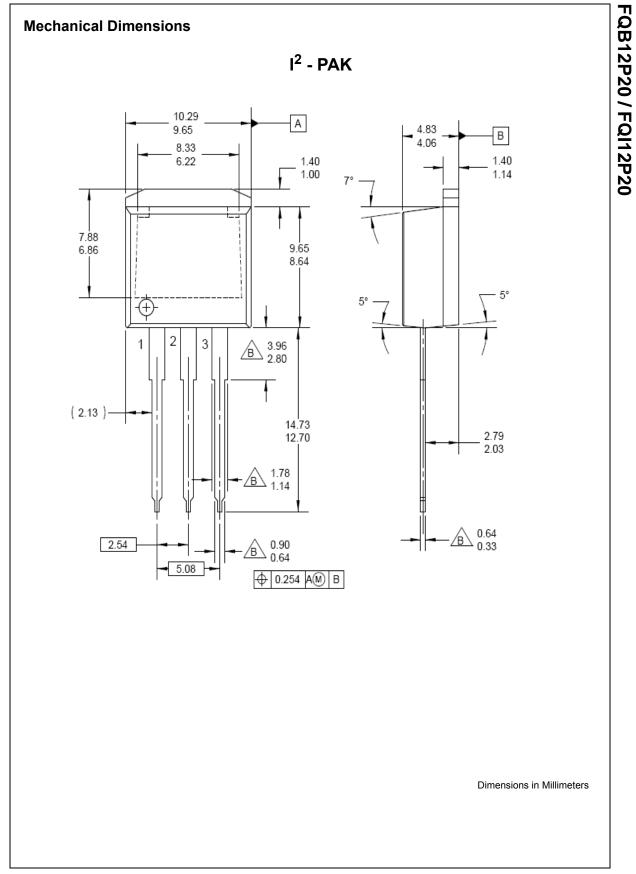


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